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PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Patent Application of:

Alin Theodor Iacob

Appln. No.: 10/635,363

Filed: August 6, 2003

For: WAFER, WAFER DICING SYSTEM, AND METHOD OF DICING THE WAFER Group Art Unit: 2826

Examiner: Tan N. Tran

RESPONSE TO RESTRICTION

REQUIREMENT AND PRELIMINARY

AMENDMENT

INTRODUCTORY COMMENTS

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sir:

This is a Response to a Restriction Requirement and a Preliminary Amendment. Please amend the above-identified application as follows:

Amendments to the Claims are reflected in the listing of claims which begins on page 2 of this paper; and

Remarks which begin on page 8 of this paper;

Adjustment date: 10/13/2004 SDIRETA1 07/26/2004 RHAWKIN1 00000003 502305 36.00 CR

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CERTIFICATE OF MAILING

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RESPONSE TO RESTRICTION REQUIREMENT AND PRELIMINARY AMENDMENT Atty. Docket No. 100-22100

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Examiner: Tran, Tan N.

REQUEST FOR REFLIND

Mail Stop 16 Director of the US Patent and Trademark Office P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sir:

Applicants' attorney received a mainthly stiffement of Deposit Account dated July 30, 2004, indicating \$36 was debited from Account No. \$12305 on July 26, 2004 for Fee Code 1202 regarding a Preliminary Amendment filled July 1, 2004 (copy enclosed). The Preliminary Amendment consists of claims 1-22 and 31-33, claims 23-30 being cancelled. There are currently 3 independent claims and 22 dependent claims, for a total of 25 total claims. The application filed on August 6, 2003, contained 3 independent claims and 28 dependent claims, for a total of 31 claims for which a check lies submitted in the amount of \$988.00 of which \$198 was for the 11 extra total claims (copy enclosed). As a result, there is no additional fee to file the Preliminary Amendment. Accordingly, applicantly attorney respectfully requests a refund in the amount of \$36 to be credited to our Deposit Account No. 502305.

Dated: 9-8-04

and I

Respectfully submitted.

Mark C. Pickering Registration No. 36,239 Attorney for Assignee

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Request for Refund



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Under the Peperwork Reduction Act of 1985 no passons 10436,263 TRANSMITTAL Files Date August 6, 2003 Alm Theodor Iscob **FORM** Group Art Usik (to be used for all correspondence after initial filling) 200 Trum, Ten N. 100-22100 (P06626) Total Number of Pages in This Submission 10 Admir Allowance Communication to Fee Transmittal Form Group Appeal Communication to Board of Appeals and Interferences Drawing(s) Fee Attached Appeal Communication to Group (Appeal Notice, Brief, Reply Brief) Response and Preliminary Amendment Doctoing related Pag Proprietary Information After Final (Response) Blatus Inquiry Affidavits/declaration(s) Other Enclosure(s)
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Amendment. Please amend the above identified application as follows:

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RESPONSE TO RESTRICTION
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AMENDA SANDARDO ALIKE AIMS

1. (Original) A semiconductor water comprising:

a plurality of semiconductor circuits formed on the semiconductor wafer, each semiconductor circuit having a pair of first sides that are parallel to each other, and a pair of second sides that are parallel to each other and perpendicular to the pair of first sides;

a plurality of first saw streets that run parallel to the first sides between a number of the semiconductor circuits;

a plurality of second saw streets that run parallel to the second sides between a number of the semiconductor strcults;

a first metal trace formed between a first saw street and a first semiconductor circuit; and

a second metal trace formed between the first saw street and a second semiconductor circuit, the first saw street lying between the first semiconductor circuit and second semiconductor circuit.

- 2. (Original) The water of claim 1 wherein the first and second metal traces extend across the water.
- 3. (Original) The water of claim, wherein the first metal trace includes a first section and a second section that lie along side the first saw street, the second section having an extension section that extends away from the second section towards the first saw street.
- 4. (Original) The water of claim 3 wherein the second section has a plurality of extension sections that extend season from the second section towards the first saw street, each extension section having a first leg and a second leg that are

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REQUIREMENT AND PRELIMINARY AMENDMENT

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connected together at a first end, and spaced spart and connected to the second section at a second end.

- 5. (Original) The water of claim 4 wherein the extension sections extend varying distances away from the second section towards the first saw street.
- 6. (Original) The water of dains 5 wherein an extension section extends into the first saw street.
- 7. (Original) The water of claim a and further comprising:
 a reference element formed adjacent to the first and second sections;
 a third metal trace that is connected to a first end of the resistive element;
 and
- a fourth metal trace that is connected to a second end of the resistive element.
- 8. (Original) The water of claim 7 wherein the reference element is a resistor.
- 9. (Original) The water of daim 3 and further comprising:
 a third metal trace that lies between the first semiconductor circuit and the
 first saw street; and

an extending section that extends away from the second section towards the first saw street, the extending section contacting the first metal trace and the third metal trace.

10. (Original) The water of claim 9 wherein the extending section extends into the first saw street.

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11. (Original) The water of claim 1 wherein:

the first metal trace runs parallel to the first saw street and then turns and runs parallel to a second saw street; and

the second metal trace runs parallel to the first saw street on an opposite side of the first saw street as the first metal trace, and then turns and runs parallel to the second saw street in an opposite direction as the first metal trace.

12. (Original) The water of claim 11 and further comprising:

a third metal trace that runs parallel to the first saw street and then turns and runs parallel to the second saw street on an opposite side of the second saw street as the first metal trace; and

a fourth metal trace that runs parallel to the first saw street and then turns and runs parallel to the second saw series in an opposite direction as the third metal trace on an opposite side of the second saw street as the second metal trace.

13. (Original) The water of Colon 12 and further comprising:

a fifth metal trace that runs parallel to a third saw street and then turns and runs parallel to a fourth saw street;

a sixth metal trace that runs parallel to the fifth metal trace along an opposite side of the third saw street and then turns size runs parallel to the fourth saw street in an opposite direction as the fifth metal trace; terminating at the first metal trace; and

a seventh metal trace that here parallel to portions of the fifth and sixth metal traces, terminating at the first metal trace.

14. (Original) The water of delth 1 wherein:

the first metal trace is formed around three sides and a portion of a fourth side of the first semiconductor circuit; and

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REQUIREMENT AND PRELIMINARY AMERICANT

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the second metal trace is formed around three sides and a portion of a fourth side of the second semiconductor circuit.

- 15. (Original) The water of claim 14 and further comprising a third metal trace formed around three sides and a portion of a fourth side of a third semiconductor circuit.
- 16. (Original) The water of claim 14 and further comprising a third metal trace formed around both the first semiconductor circuit and a third semiconductor circuit.
- 17. '(Original) The water of claim 14 wherein the first and second metal traces are formed in a first level; and further comprising a third metal trace formed around three sides and a portion of a fourth side of the first semiconductor circuit, the third metal trace lying above and being special apart from the first metal trace.
 - 18. ' (Original) A wafer dicing system comprising:

a resistance measuring evalum that measures the resistances of a plurality of metal traces formed on a wafer; and

a system controller connected to the resistance measuring system that controls the resistance measuring system and processes the resistance values measured by the resistance measuring system.

- 19. (Original) The water diding system of claim 18 wherein the resistance measuring system includes:
 - a first multiplexer;
 - a second multiplexer; and
- a resistance detector connected to the first and second multiplexers and the system controller.

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707-762-5504 Mark C. Pi

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- The water diding system of claim 19 and further (Original) 20. comprising:
 - a cutting device; and
 - a cutting controller connected to the cutting device and the system controller.
- The water dicing system of claim 18 wherein the (Original) 21. resistance measuring system includes:
 - a plurality of resistance detectors; and
- a multiplexer connected to the plurality of resistance detectors and the system controller.
- The water cloing system of claim 21 and further 22. (Original) comprising:
 - a cutting device; and
 - a cutting controller connected to the cutting device and the system controller.

Claims 23-30 (Cancelled)

- The water dicing system of claim 18 wherein the system (Original) 31. controller outputs a maintenance signal that indicates that maintenance is necessary.
 - (New) A semiconductor water comprising: 32.

a plurality of semiconductor circults formed on the semiconductor wafer, each semiconductor circuit having a pair of first sides that are parallel to each other, and a pair of second sides that are parallel to each other and perpendicular to the pair of first sides; !

RESPONSE TO RESTRICTION REQUIREMENT AND PRELIMINARY AMENDMENT Atty. Docket No. 100-22100

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a plurality of first saw streets that run parallel to the first sides between a number of the semiconductor circuits; and a plurality of second saw streets that run parallel to the second sides between a number of the semiconductor droults.

33. (New) The semiconductor wafer of claim 32 and further comprising a first metal trace formed between a first saw street and a first semiconductor circuit.

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This is a response to a restriction requirement and a preliminary amendment. The Examiner required that the invention be restricted to claims 1-22 and 31 which are drawn to a semiconductor device, or claims 23-30 which are drawn to a method of manufacturing a semiconductor device. As a result, applicant elects to prosecute claims 1-22 and 31 without traverse. In addition, by way of preliminary amendment, applicant has cancelled non-elected claims 23-30, and added claims 32-33 to additionally claim the present invention. As a result, claims 1-22 and 31-33 are currently pending.

Respectfully submitted,

Dated: 1-1-04

Mark C. Pickering

Registration No. 36,239 Attorney for Assignee

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